### **Power MOSFET**

## 60 V, 8.9 m $\Omega$ , 48 A, Single N-Channel

#### **Features**

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			$V_{DSS}$	60	V
Gate-to-Source Voltage			$V_{GS}$	±20	V
Continuous Drain Cur-		$T_C = 25^{\circ}C$	I <sub>D</sub>	48	Α
rent R <sub>θJC</sub> (Notes 1 & 3)	Steady	T <sub>C</sub> = 100°C		34	
Power Dissipation R <sub>θJC</sub>	State	T <sub>C</sub> = 25°C	P <sub>D</sub>	42	W
(Note 1)		$T_C = 100^{\circ}C$		21	
Continuous Drain Cur-		T <sub>A</sub> = 25°C	I <sub>D</sub>	15	Α
rent $R_{\theta JA}$ (Notes 1, 2 & 3)	Steady	T <sub>A</sub> = 100°C		10	
Power Dissipation R <sub>θJA</sub>	State	T <sub>A</sub> = 25°C	$P_{D}$	4.0	W
(Notes 1 & 2)		T <sub>A</sub> = 100°C		2.0	
Pulsed Drain Current	$T_A = 25^{\circ}$	C, t <sub>p</sub> = 10 μs	I <sub>DM</sub>	250	Α
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>stg</sub>	-55 to 175	ç
Source Current (Body Diode)			I <sub>S</sub>	25	Α
Single Pulse Drain-to-Source Avalanche Energy (I <sub>L(pk)</sub> = 3 A)			E <sub>AS</sub>	104	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain) (Note 1)	$R_{\theta JC}$	3.6	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	37	

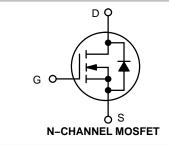
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface–mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.
- 3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.



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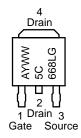
V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub>	I <sub>D</sub>	
60 V	8.9 mΩ @ 10 V	49 A	
	12.8 mΩ @ 4.5 V	49 (	





DPAK CASE 369C STYLE 2

# MARKING DIAGRAM & PIN ASSIGNMENT



A = Assembly Location

Y = Year
WW = Work Week
5C668L = Device Code
G = Pb-Free Package

#### **ORDERING INFORMATION**

See detailed ordering and shipping information in the package dimensions section on page 5 of this data sheet.

### **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•						
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> :	= 250 μΑ	60			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				27		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C			10	μΑ
		$V_{DS} = 60 \text{ V}$	T <sub>J</sub> = 125°C			250	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{G}$	<sub>S</sub> = 20 V			100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_{D}$	= 50 μΑ	1.2		2.1	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				4.8		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>I</sub>	<sub>O</sub> = 25 A		7.4	8.9	mΩ
		V <sub>GS</sub> = 4.5 V, I	<sub>D</sub> = 25 A		10.2	12.8	
Forward Transconductance	9 <sub>FS</sub>	V <sub>DS</sub> = 15 V, I <sub>E</sub>	<sub>O</sub> = 25 A		60		S
CHARGES, CAPACITANCES AND GATE RE	SISTANCES				•		
Input Capacitance	C <sub>iss</sub>	$V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz,}$ $V_{DS} = 25 \text{ V}$			1300		pF
Output Capacitance	C <sub>oss</sub>				580		
Reverse Transfer Capacitance	C <sub>rss</sub>				18		
Total Gate Charge		V <sub>GS</sub> = 4.5 V		8.7		nC	
			V <sub>GS</sub> = 10 V		18.7		1
Threshold Gate Charge	Q <sub>G(TH)</sub>				2.4		nC
Gate-to-Source Charge	Q <sub>GS</sub>	$V_{GS} = 4.5 \text{ V}, V_{DS} = 30 \text{ V},$ $I_{D} = 25 \text{ A}$			4.1		
Gate-to-Drain Charge	$Q_GD$				2.0		
Plateau Voltage	$V_{GP}$				3.1		V
SWITCHING CHARACTERISTICS (Note 5)	<u> </u>						
Turn-On Delay Time	$t_{d(on)}$				12		ns
Rise Time	t <sub>r</sub>	Voc = 45 V Vr	oc = 30 V		74		
Turn-Off Delay Time	t <sub>d(off)</sub>	$V_{GS} = 4.5 \text{ V}, V_{I}$ $I_{D} = 25 \text{ A}, R_{G}$	$= 2.5 \Omega$		26		
Fall Time	t <sub>f</sub>				62		
DRAIN-SOURCE DIODE CHARACTERISTIC	S					ı	
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 20 A	T <sub>J</sub> = 25°C		0.87	1.2	V
Ç			T <sub>J</sub> = 125°C		0.76		1
Reverse Recovery Time	t <sub>RR</sub>		<u> </u>		32		ns
Charge Time	ta	V00 = 0 \/ dl = /d+	– 100 A/us		15		1
Discharge Time	tb	$V_{GS} = 0 \text{ V, } dI_{S}/dt = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 25 \text{ A}$			16		1
Reverse Recovery Charge	Q <sub>RR</sub>				20		nC

Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

#### TYPICAL CHARACTERISTICS

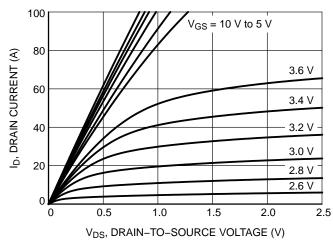
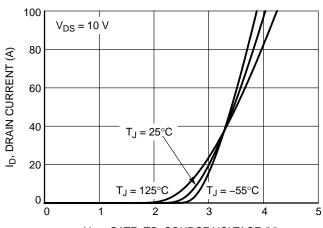


Figure 1. On-Region Characteristics



V<sub>GS</sub>, GATE-TO-SOURCE VOLTAGE (V)
Figure 2. Transfer Characteristics

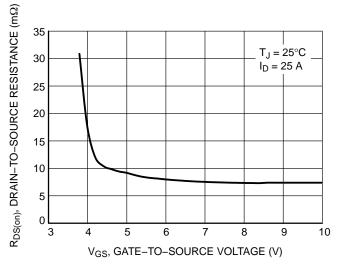


Figure 3. On-Resistance vs. Gate-to-Source Voltage

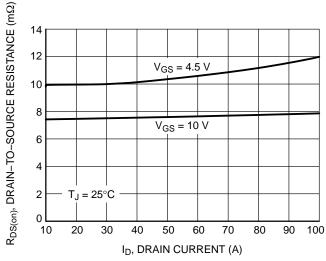


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

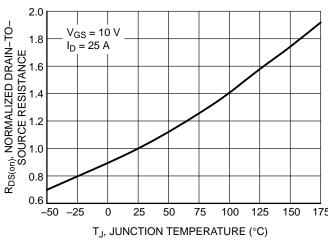


Figure 5. On–Resistance Variation with Temperature

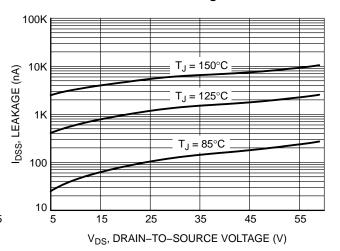


Figure 6. Drain-to-Source Leakage Current vs. Voltage

#### **TYPICAL CHARACTERISTICS**

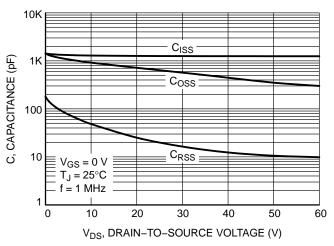


Figure 7. Capacitance Variation

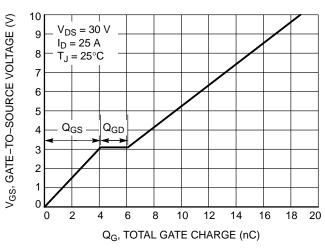


Figure 8. Gate-to-Source vs. Total Charge

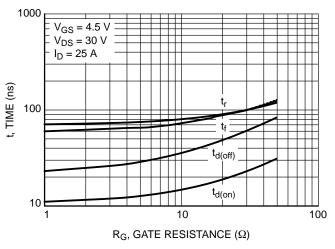


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

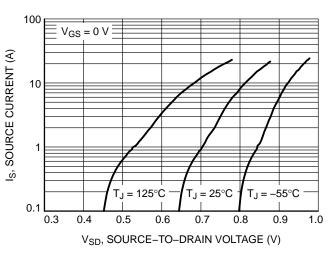


Figure 10. Diode Forward Voltage vs. Current

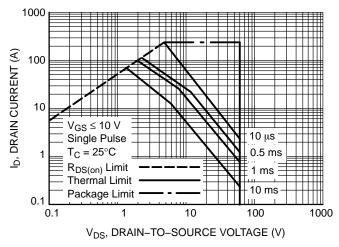


Figure 11. Maximum Rated Forward Biased Safe Operating Area

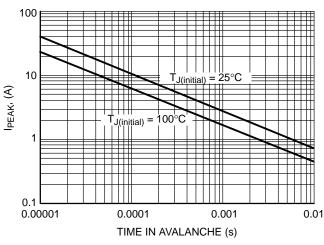


Figure 12. Maximum Drain Current vs. Time in Avalanche

### **TYPICAL CHARACTERISTICS**

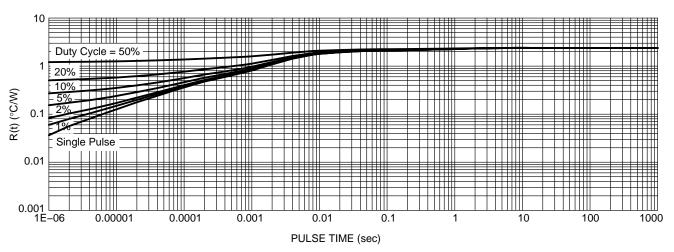


Figure 13. Thermal Response

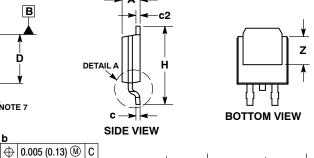
#### **ORDERING INFORMATION**

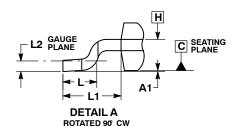
Order Number	Package	Shipping <sup>†</sup>
NTD5C668NLT4G	DPAK (Pb-Free)	2500 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.



## **DPAK (SINGLE GAUGE)** CASE 369C ISSUE F SCALE 1:1 Α <-b3 В L3 ۩ **DETAIL A**

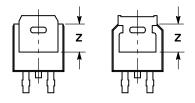




**TOP VIEW** 

NOTE 7

h2 е

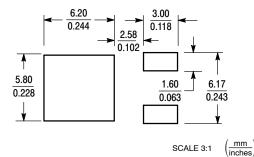


**BOTTOM VIEW** ALTERNATE CONSTRUCTIONS

STYLE 1:	STYLE 2:	STYLE 3:	STYLE 4:	STYLE 5:
PIN 1. BASE	PIN 1. GATE	PIN 1. ANODE	PIN 1. CATHODE	PIN 1. GATE
2. COLLECTOR	2. DRAIN	2. CATHODE	2. ANODE	2. ANODE
3. EMITTER	3. SOURCE	3. ANODE	3. GATE	3. CATHODE
4. COLLECTOR	4. DRAIN	4. CATHODE	4. ANODE	4. ANODE
STVLE 6: STVLE	7· STVI	F 8· STVI I	F o·	STVI F 10.

STYLE 6:	STYLE 7:	STYLE 8:	STYLE 9:	STYLE 10:
PIN 1. MT1	PIN 1. GATE	PIN 1. N/C	PIN 1. ANODE	PIN 1. CATHODE
2. MT2	2. COLLECTOR	2. CATHODE	2. CATHODE	2. ANODE
3. GATE	3. EMITTER	3. ANODE	3. RESISTOR ADJUST	3. CATHODE
4. MT2	4. COLLECTOR	4. CATHODE	4. CATHODE	4. ANODE

#### **SOLDERING FOOTPRINT\***



<sup>\*</sup>For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

**DATE 21 JUL 2015** 

- NOTES:

  1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.

  2. CONTROLLING DIMENSION: INCHES.

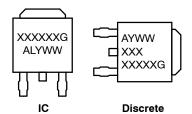
  3. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS OF THE PROPERTY OF THE PR

- MENSIONS b3, L3 and Z.
  4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.
  5. DIMENSIONS D AND E ARE DETERMINED AT THE
- OUTERMOST EXTREMES OF THE PLASTIC BODY.

  6. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.
  7. OPTIONAL MOLD FEATURE.

	INCHES		MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.086	0.094	2.18	2.38
A1	0.000	0.005	0.00	0.13
b	0.025	0.035	0.63	0.89
b2	0.028	0.045	0.72	1.14
b3	0.180	0.215	4.57	5.46
С	0.018	0.024	0.46	0.61
c2	0.018	0.024	0.46	0.61
D	0.235	0.245	5.97	6.22
E	0.250	0.265	6.35	6.73
е	0.090	BSC	2.29 BSC	
Н	0.370	0.410	9.40	10.41
L	0.055	0.070	1.40	1.78
L1	0.114 REF		2.90 REF	
L2	0.020 BSC		0.51	BSC
L3	0.035	0.050	0.89	1.27
L4		0.040		1.01
Z	0.155		3.93	

#### **GENERIC MARKING DIAGRAM\***



XXXXXX = Device Code = Assembly Location Α L = Wafer Lot Υ = Year WW = Work Week = Pb-Free Package

DOCUMENT NUMBER:	98AON10527D	Electronic versions are uncontrolled except when accessed directly from the Document Re Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.	
DESCRIPTION:	DPAK (SINGLE GAUGE)		PAGE 1 OF 1

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<sup>\*</sup>This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "=", may or may not be present. Some products may not follow the Generic Marking.

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